

1AP20 REG'D 1/30/06 30 JAN 2006

INFORMATION DISCLOSURE STATEMENT

Applicant : Yamazaki et al.
App. No : Unknown
Filed : Herewith
For : POSITIVE RESIST COMPOSITION
AND METHOD OF FORMING
RESIST PATTERN
Examiner : Unassigned
Art Unit : Unknown

CERTIFICATE OF MAILING

I hereby certify that this correspondence and all marked attachments are being deposited with the United States Postal Service as first-class mail in an envelope addressed to: Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450, on

January 30, 2006

Neil S. Bartfeld, Ph.D., Reg. No. 39,901

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Dear Sir:

Enclosed for filing in the above-identified application is a PTO/SB/08 Equivalent listing 6 references to be considered by the Examiner. Also enclosed are 3 foreign patent references and/or non-patent literature as listed on the Information Disclosure Statement.

This Information Disclosure Statement is being filed within three months of the filing date, with an RCE or before receipt of a first office action after an RCE and no fee is required.

The Commissioner is hereby authorized to charge any additional fees which may be required, or credit any overpayment, to Account No. 11-1410.

Respectfully submitted,

KNOBBE, MARTENS, OLSON & BEAR, LLP

Dated:

January 30, 2006

By:

Neil S. Bartfeld, Ph.D.
Registration No. 39,901
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PTO/SB/08 Equivalent

INFORMATION DISCLOSURE STATEMENT BY APPLICANT	Application No.	Unknown	
	Filing Date	Herewith 80/566425	
	First Named Inventor	Akiyoshi Yamazaki	
	Art Unit	Unknown	
	Examiner	Unassigned	
(Multiple sheets used when necessary)		Attorney Docket No.	SHIGA7.044APC
SHEET 1 OF 1			

U.S. PATENT DOCUMENTS					
Examiner Initials	Cite No.	Document Number Number - Kind Code (if known) Example: 1,234,567 B1	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Pages, Columns, Lines Where Relevant Passages or Relevant Figures Appear
	1	5,216,135	06-01-1993	Urano et al.	
	2	6,368,980 B1	04-09-2002	Minami et al.	
	3	6,485,895 B1	11-26-2002	Choi et al.	

FOREIGN PATENT DOCUMENTS						
Examiner Initials	Cite No.	Foreign Patent Document Country Code-Number-Kind Code Example: JP 1234567 A1	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Pages, Columns, Lines Where Relevant Passages or Relevant Figures Appear	T ¹
	4	JP 04-211258 A	08-03-1992	Fumiyoshi et al.		✓
	5	JP 2000-188250 A	07-04-2000	Akiyuki et al.		✓
	6	JP 2000-356850	12-26-2000	Choi et al.		✓

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Examiner Signature	/John Chu/	Date Considered	05/12/2008
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*Examiner: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

T¹ - Place a check mark in this area when an English language translation is attached.

ALL REFERENCES CONSIDERED EXCEPT WHERE LINED THROUGH. /JSC/